

ATmega88/168 Automotive

Appendix A - Atmel ATmega88/168 Automotive Specification at 150°C

DATASHEET

Description

This document contains information specific to devices operating at temperatures up to 150°C. Only deviations are covered in this appendix, all other information can be found in the complete Automotive datasheet. The complete Automotive datasheet can be found on http://www.atmel.com

1. Electrical Characteristics

1.1 Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Test Conditions	Unit
Operating temperature	-55 to +150	°C
Storage temperature	-65 to +175	°C
Voltage on any pin except RESET with respect to ground	-0.5 to V_{CC} +0.5	V
Voltage on RESET with respect to ground	-0.5 to +13.0	V
Maximum operating voltage	6.0	V
DC current per I/O pin DC current V _{CC} and GND	30 200.0	mA

1.2 DC Characteristics

 $T_A = -40$ °C to +150°C, $V_{CC} = 2.7$ V to 5.5V (unless otherwise noted)

Parameters	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
Input low voltage, except XTAL1 and RESET pin	V _{CC} = 2.7V to 5.5V	V _{IL}	-0.5		+0.3V _{CC} ⁽¹⁾	V
Input high voltage, except XTAL1 and RESET pins	V _{CC} = 2.7V to 5.5V	V_{IH}	0.6V _{CC} ⁽²⁾		V _{CC} + 0.5	V
Input low voltage, XTAL1 pin	V _{CC} = 2.7V to 5.5V	V_{IL1}	-0.5		+0.1V _{CC} ⁽²⁾	V
Input high voltage, XTAL1 pin	V _{CC} = 2.7V to 5.5V	V _{IH1}	0.7V _{CC} ⁽²⁾		V _{CC} + 0.5	V
Input low voltage, RESET pin	V _{CC} = 2.7V to 5.5V	$V_{\text{IL}2}$	-0.5		+0.2V _{CC} ⁽¹⁾	V
Input high voltage, RESET pin	V _{CC} = 2.7V to 5.5V	V_{IH2}	0.9V _{CC} ⁽²⁾		V _{CC} + 0.5	V

- Notes: 1. "Max" means the highest value where the pin is guaranteed to be read as low
 - 2. "Min" means the lowest value where the pin is guaranteed to be read as high
 - 3. Although each I/O port can sink more than the test conditions (20mA at V_{CC} = 5V) under steady state conditions (non-transient), the following must be observed:
 - 1] The sum of all IOL, for all ports, should not exceed 400mA.
 - 2] The sum of all IOL, for ports C0 C5, should not exceed 200mA.
 - 3] The sum of all IOL, for ports C6, D0 D4, should not exceed 300mA.
 - 4] The sum of all IOL, for ports B0 B7, D5 D7, should not exceed 300mA.
 - If IOL exceeds the test condition, VOL may exceed the related specification. Pins are not guaranteed to sink current greater than the listed test condition.
 - 4. Although each I/O port can source more than the test conditions (20mA at V_{CC} = 5V) under steady state conditions (non-transient), the following must be observed:
 - 1] The sum of all IOH, for all ports, should not exceed 400mA.
 - 2] The sum of all IOH, for ports C0 C5, should not exceed 200mA.
 - 3] The sum of all IOH, for ports C6, D0 D4, should not exceed 300mA.
 - 4] The sum of all IOH, for ports B0 B7, D5 D7, should not exceed 300mA.
 - If IOH exceeds the test condition, VOH may exceed the related specification. Pins are not guaranteed to source current greater than the listed test condition.
 - 5. Minimum V_{CC} for Power-down is 2.5V



1.2 DC Characteristics (Continued)

 $T_A = -40$ °C to +150°C, $V_{CC} = 2.7$ V to 5.5V (unless otherwise noted)

Parameters	Test Conditions	Symbol	Min.	Тур.	Max.	Unit
Input low voltage, RESET pin as I/O	V _{CC} = 2.7V to 5.5V	V_{IL3}	-0.5		+0.3V _{CC} ⁽¹⁾	V
Input high voltage, RESET pin as I/O	V _{CC} = 2.7V to 5.5V	V_{IH3}	0.6V _{CC} ⁽²⁾		V _{CC} + 0.5	V
Output low voltage ⁽³⁾ , I/O pin except RESET	$I_{OL} = 20$ mA, $V_{CC} = 5$ V $I_{OL} = 5$ mA, $V_{CC} = 3$ V	V_{OL}			0.8 0.5	V
Output high voltage ⁽⁴⁾ I/O pin except RESET	$I_{OH} = -20 \text{mA}, V_{CC} = 5 \text{V}$ $I_{OH} = -10 \text{mA}, V_{CC} = 3 \text{V}$	V_{OH}	4.0 2.2			V
Input leakage current I/O pin	V _{CC} = 5.5V, pin low (absolute value)	I _{IL}			1	μΑ
Input leakage current I/O pin	V _{CC} = 5.5V, pin high (absolute value)	I _{IH}			1	μΑ
Reset pull-up resistor		R_{RST}	30		60	$k\Omega$
I/O pin pull-up resistor		R_{PU}	20		50	kΩ
Power supply current ⁽⁵⁾	Active 4MHz, $V_{CC} = 3V$ Active 8MHz, $V_{CC} = 5V$	I_{CC}			8 16	mA
	Active 16MHz, V_{CC} = 5V				25	mA
Tower supply current	Idle 4MHz, $V_{CC} = 3V$ Idle 8MHz, $V_{CC} = 5V$	I _{CC IDLE}			6 12	mA
	Idle 16MHz, V _{CC} = 5V				14	mA
Power-down mode	WDT enabled, $V_{CC} = 3V$ WDT enabled, $V_{CC} = 5V$				90 140	μΑ
rower-down mode	WDT disabled, $V_{CC} = 3V$ WDT disabled, $V_{CC} = 5V$	I _{CC PWD}			80 120	μΑ
Analog comparator input offset voltage	$V_{CC} = 5V$ $V_{in} = V_{CC}/2$	V_{ACIO}		< 10	40	mV
Analog comparator input leakage current	$V_{CC} = 5V$ $V_{in} = V_{CC}/2$	I _{ACLK}	– 50		+50	nA
Analog comparator propagation delay	V _{CC} = 4.0V	t _{ACPD}		500		ns

- Notes: 1. "Max" means the highest value where the pin is guaranteed to be read as low
 - 2. "Min" means the lowest value where the pin is guaranteed to be read as high
 - 3. Although each I/O port can sink more than the test conditions (20mA at V_{CC} = 5V) under steady state conditions (non-transient), the following must be observed:
 - 1] The sum of all IOL, for all ports, should not exceed 400mA.
 - 2] The sum of all IOL, for ports C0 C5, should not exceed 200mA.
 - 3] The sum of all IOL, for ports C6, D0 D4, should not exceed 300mA.
 - 4] The sum of all IOL, for ports B0 B7, D5 D7, should not exceed 300mA.
 - If IOL exceeds the test condition, VOL may exceed the related specification. Pins are not guaranteed to sink current greater than the listed test condition.
 - 4. Although each I/O port can source more than the test conditions (20mA at V_{CC} = 5V) under steady state conditions (non-transient), the following must be observed:
 - 1] The sum of all IOH, for all ports, should not exceed 400mA.
 - 2] The sum of all IOH, for ports C0 C5, should not exceed 200mA.
 - 3] The sum of all IOH, for ports C6, D0 D4, should not exceed 300mA.
 - 4] The sum of all IOH, for ports B0 B7, D5 D7, should not exceed 300mA.
 - If IOH exceeds the test condition, VOH may exceed the related specification. Pins are not guaranteed to source current greater than the listed test condition.
 - 5. Minimum V_{CC} for Power-down is 2.5V



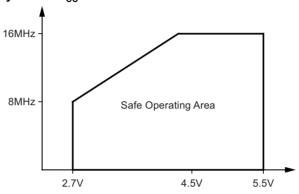
1.3 **Memory Endurance**

EEPROM endurance: 50,000 write/erase cycles. Flash endurance: 10,000 write/erase cycles.

Maximum Speed versus V_{CC} 1.4

Maximum frequency is dependent on V_{CC} . As shown in Figure 1-1, the maximum frequency versus V_{CC} curve is linear between 2.7V < V_{CC} < 4.5V.

Figure 1-1. Maximum Frequency versus V_{CC}



ADC Characteristics(1) 1.5

 $T_A = -40$ °C to +150°C, $V_{CC} = 4.5$ V to 5.5V (unless otherwise noted)

Parameters	Test Conditions	Symbol	Min	Тур	Max	Unit
Resolution				10		Bits
Absolute accuracy	V_{REF} = 4V, V_{CC} = 4V, ADC clock = 200kHz			2	3.5	LSB
(including INL, DNL, quantization error, gain and offset error)	V_{REF} = 4V, V_{CC} = 4V, ADC clock = 200kHz Noise reduction mode			2	3.5	LSB
Integral non-linearity (INL)	V_{REF} = 4V, V_{CC} = 4V, ADC clock = 200kHz			0.6	2.5	LSB
Differential non-linearity (DNL)	V_{REF} = 4V, V_{CC} = 4V, ADC clock = 200kHz			0.30	1.0	LSB
Gain error	V_{REF} = 4V, V_{CC} = 4V, ADC clock = 200kHz		-3.5	-1.3	+3.5	LSB
Offset error	V_{REF} = 4V, V_{CC} = 4V, ADC clock = 200kHz			1.8	3.5	LSB
Conversion time	Free running conversion		13 cycles			μs
Clock frequency			50		200	kHz
Analog supply voltage		AV_CC	$V_{\rm CC}-0.3$		V _{CC} + 0.3	V
Reference voltage		V_{REF}	1.0		AV_CC	V
Input voltage		V_{IN}	GND		V_{REF}	V
Input bandwidth				38.5		kHz
Internal voltage reference		V_{INT}	1.0	1.1	1.2	V
Reference input resistance		R_{REF}	25.6	32	38.4	kΩ
Analog input resistance		R _{AIN}		100		$M\Omega$

1. Based on standard voltage range (2.7V to 5.5V) characterization results. To be confirmed after actual silicon Note: characterization.



2. ATmega88/168 Typical Characteristics

2.1 Active Supply Current

Figure 2-1. Active Supply Current versus Frequency (1MHz to 20MHz)

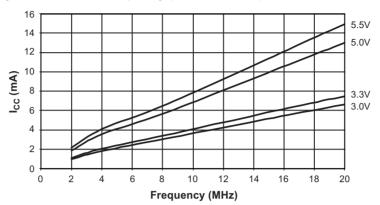
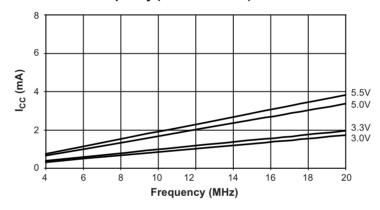


Figure 2-2. Idle Supply Current versus Frequency (1MHz to 20MHz)



2.2 Power-Down Supply Current

Figure 2-3. Power-down Supply Current versus V_{CC} (Watchdog Timer Disabled)

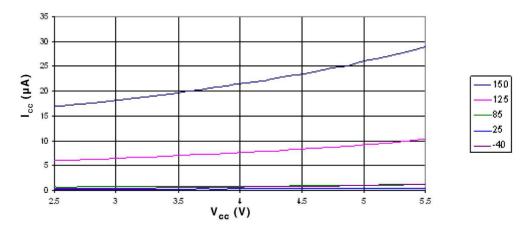
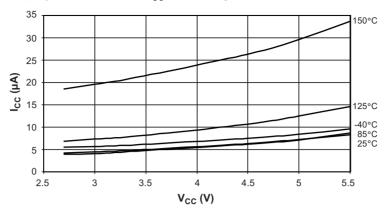




Figure 2-4. Power-down Supply Current versus V_{CC} (Watchdog Timer Enabled)



2.3 Pin Pull-up

Figure 2-5. I/O Pin Pull-up Resistor Current versus Input Voltage (V_{CC} = 5V)

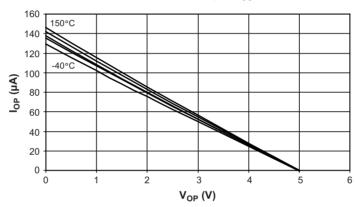


Figure 2-6. Output Low Voltage versus Output Low Current (V_{CC} = 5V)

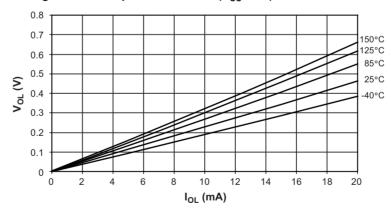


Figure 2-7. Output Low Voltage versus Output Low Current (V_{CC} = 3V)

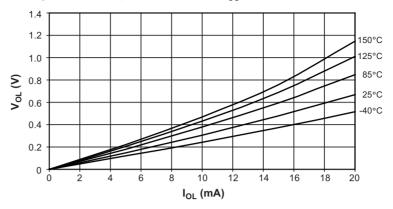


Figure 2-8. Output High Voltage versus Output High Current ($V_{CC} = 5V$)

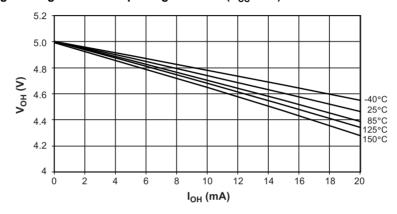


Figure 2-9. Output High Voltage versus Output High Current ($V_{CC} = 3V$)

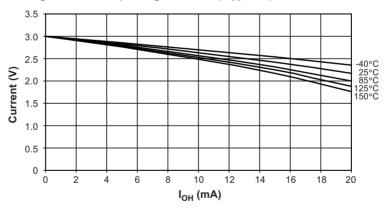
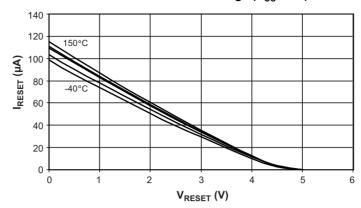




Figure 2-10. Reset Pull-up Resistor Current versus Reset Pin Voltage (V_{CC} = 5V)



2.4 Pin Thresholds and Hysteresis

Figure 2-11. I/O Pin Input Threshold versus V_{CC} (VIH, I/O Pin Read as '1')

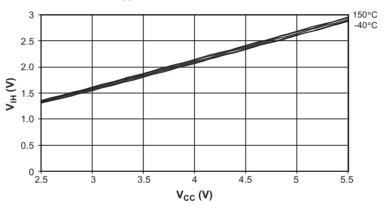


Figure 2-12. I/O Pin Input Threshold versus V_{CC} (VIL, I/O Pin Read as '0')

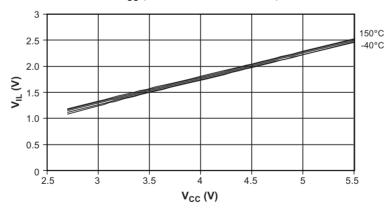


Figure 2-13. Reset Input Threshold Voltage versus V_{CC} (VIH, Reset Pin Read as '1')

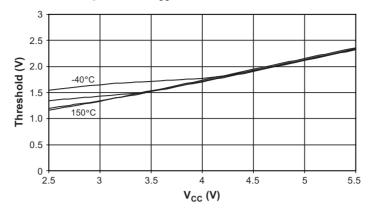
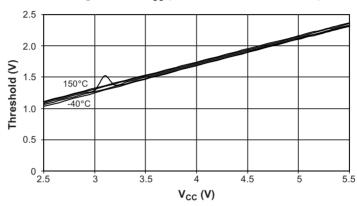


Figure 2-14. Reset Input Threshold Voltage versus V_{CC} (VIL, Reset Pin Read as '0')



2.5 Internal Oscillator Speed

Figure 2-15. Watchdog Oscillator Frequency versus V_{CC}

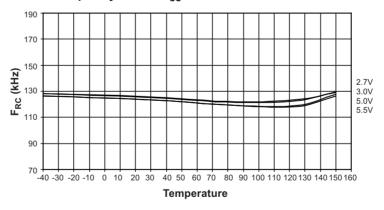




Figure 2-16. Calibrated 8MHz RC Oscillator Frequency versus Temperature

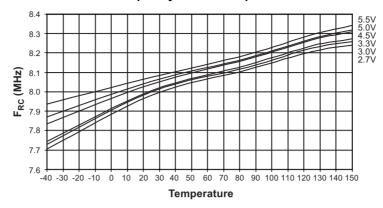


Figure 2-17. Calibrated 8MHz RC Oscillator Frequency versus V_{CC}

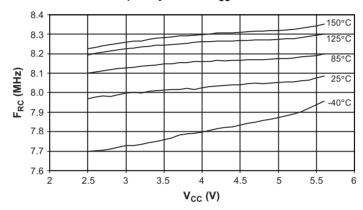
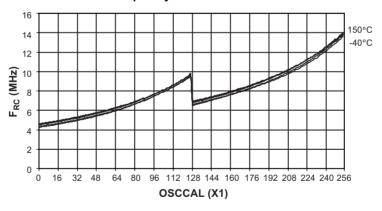


Figure 2-18. Calibrated 8MHz RC Oscillator Frequency versus OSCCAL Value



2.6 BOD Thresholds and Analog Comparator Offset

Figure 2-19. BOD Threshold versus Temperature (BODLEVEL is 4.0V)

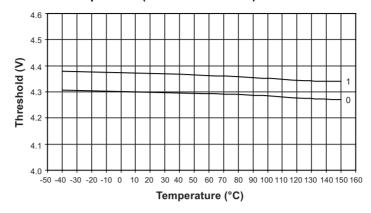


Figure 2-20. BOD Threshold versus Temperature (BODLEVEL is 2.7V)

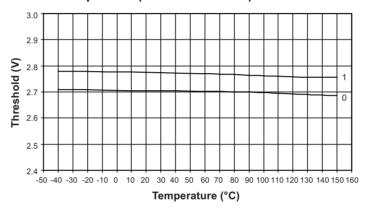
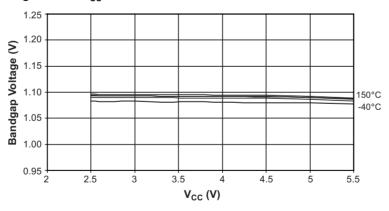


Figure 2-21. Bandgap Voltage versus V_{CC}





2.7 Peripheral Units

Figure 2-22. Analog to Digital Converter GAIN versus V_{CC}

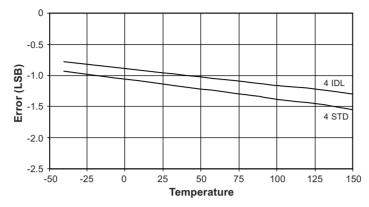


Figure 2-23. Analog to Digital Converter OFFSET versus \mathbf{V}_{CC}

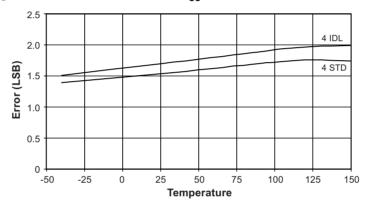
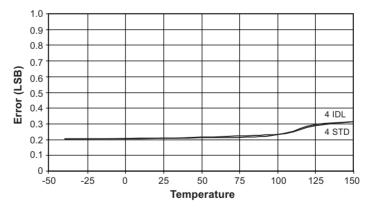


Figure 2-24. Analog to Digital Converter DNL versus V_{CC}



1 0 0.9 0.8 0.7 Error (LSB) 0.6 4 IDL 0.5 4 STD 0.4 0.3 0.2 0.1 -25 0 25 50 100 125 150

Figure 2-25. Analog to Digital Converter INL versus V_{CC}

2.8 **Grade 0 Qualification**

The ATmega88/168 has been developed and manufactured according to the most stringent quality assurance requirements of ISO-TS-16949 and verified during product qualification as per AEC-Q100 grade 0.

Temperature

AEC-Q100 qualification relies on temperature accelerated stress testing. High temperature field usage however may result in less significant stress test acceleration. In order to prevent the risk that ATmega88/168 lifetime would not satisfy the application end-of-life reliability requirements, Atmel® has extended the testing, whenever applicable (High Temperature Operating Life Test, High Temperature Storage Life, Data Retention, Thermal Cycles), far beyond the AEC-Q100 requirements. Thereby, Atmel verified the ATmega88/168 has a long safe lifetime period after the grade 0 gualification acceptance limits.

The valid domain calculation depends on the activation energy of the potential failure mechanism that is considered. Examples are given in Figure 2-26. Therefore any temperature mission profile which could exceed the AEC-Q100 equivalence domain shall be submitted to Atmel for a thorough reliability analysis.

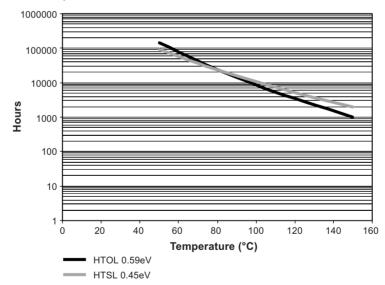


Figure 2-26. AEC-Q100 Lifetime Equivalence



3. Ordering Information

Table 3-1. ATmega88/168

Speed (MHz)	Power Supply	Ordering Code	Package ⁽¹⁾	Operation Range
16 ⁽²⁾	2.7V to 5.5V	ATmega88-15MT2	PN	Extended (-40°C to +150°C)
16 ⁽²⁾	2.7V to 5.5V	ATmega88-15AD	MA	Extended (-40°C to +150°C)
16 ⁽²⁾	2.7V to 5.5V	ATmega168-15MD	PN	Extended (-40°C to +150°C)
16 ⁽²⁾	2.7V to 5.5V	ATmega168-15AD	MA	Extended (-40°C to +150°C)

Notes: 1.

- Pb-free packaging, complies to the European Directive for Restriction of Hazardous Substances (RoHS directive). Also halide free and fully green.
- 2. For speed versus V_{cc} , see complete datasheet.

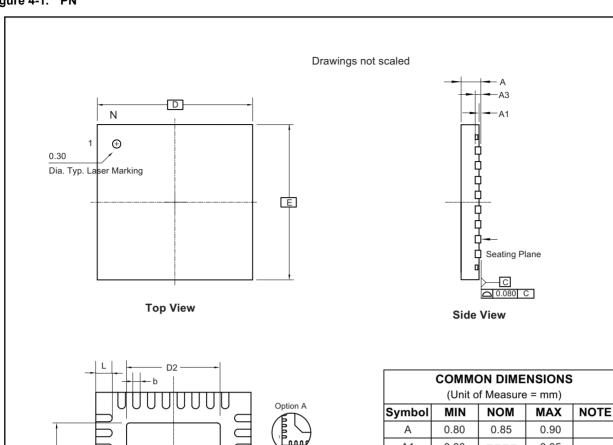
4. Package Information

Table 4-1. Package Types

	Package Type
PN	32-pad, $5 \times 5 \times 1.0$ mm body, lead pitch 0.50mm, quad flat no-lead/micro lead frame package (QFN/MLF): E2/D2 3.1 ± 0.1 mm
MA	$32 - Lead, 7 mm \times 7 mm \ body \ size, 1.0 mm \ body \ thickness \ 0.8 mm \ lead \ pitch, \ thin \ profile \ plastic \ quad \ flat \ package \ (TQFP)$

Figure 4-1. PN

E2



L D2					
- b			СОММ	ON DIME	NSIONS
			(Unit c	of Measure	= mm)
Handand	Option A	Symbol	MIN	NOM	MAX
	(<u>F</u>	Α	0.80	0.85	0.90
		A1	0.00		0.05
	Pin 1# Chamfer (C 0.30)	A3		0.20 REF	
	Option B	D/E		5.00 BSC	
PIN1 ID		D2/E2	3.00	3.10	3.20
	ر قیمی	L	0.30	0.40	0.50
	Pin 1# Notch	b	0.18	0.25	0.30
N N N N N N N N N N N N N N N N N N N	(C 0.20 R)	е		0.50 BSC	
See Options A, B		n		32	
Bottom View					

Notes: 1. This drawing is for general information only. Refer to JEDEC Drawing MO-220, Variation VHHD-2, for proper dimensions, tolerances, datums, etc.
 Dimensions b applies to metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
 If the terminal has the optical radius on the other end of the terminal, the dimensions should not be measured in that radius area.

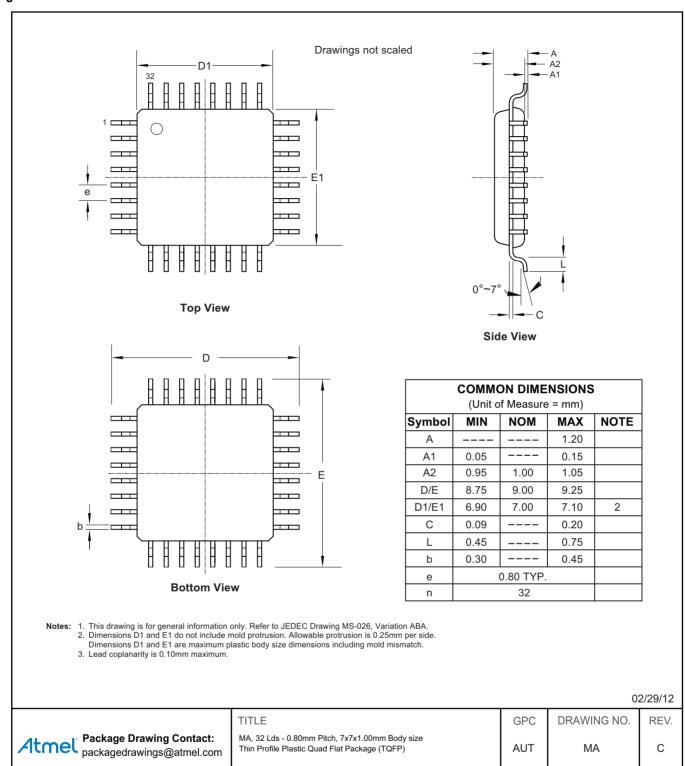
01/31/12

2





Figure 4-2. MA



5. Revision History

Please note that the following page numbers referred to in this section refer to the specific revision mentioned, not to this document.

Revision No.	History
7607J-AVR-07/14	Put datasheet in the latest template
7607I-AVR-03/12	Section 4 "Package Information" on pages 15 to 16 changed
7607H-AVR-02/10	• Table 4-1 "Package Types" on page 15 changed
7607G-AVR-07/09	Package MA updated
7607F-AVR-01/08	• Added memory endurance. See Section 1.3 "Memory Endurance" on page 4
7607E-AVR-11/07	Added ATMega168 product offering
7007 L-AVIN-11707	Added MA package offering
	Updated electrical characteristics
7607D-AVR-03/07	Removed Grade0 qualification section
	Updated product part number in ordering information
7607C-AVR-09/06	Ordering and package information updated
7607B-AVR-08/06	Added typical characteristics
7607A-AVR-01/06	Document Creation















Atmel Corporation

1600 Technology Drive, San Jose, CA 95110 USA

T: (+1)(408) 441.0311

F: (+1)(408) 436.4200

www.atmel.com

© 2014 Atmel Corporation. / Rev.: Rev.: 7607J-AVR-07/14

Atmel®, Atmel logo and combinations thereof, Enabling Unlimited Possibilities®, AVR®, and others are registered trademarks or trademarks of Atmel Corporation in U.S. and other countries. Other terms and product names may be trademarks of others.

DISCLAIMER: The information in this document is provided in connection with Atmel products. No license, express or implied, by estoppel or otherwise, to any intellectual property right is granted by this document or in connection with the sale of Atmel products. EXCEPT AS SET FORTH IN THE ATMEL TERMS AND CONDITIONS OF SALES LOCATED ON THE ATMEL WEBSITE, ATMEL ASSUMES NO LIABILITY WHATSOEVER AND DISCLAIMS ANY EXPRESS, IMPLIED OR STATUTORY WARRANTY RELATING TO ITS PRODUCTS INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTY OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT. IN NO EVENT SHALL ATMEL BE LIABLE FOR ANY DIRECT, INDIRECT, CONSEQUENTIAL, PUNITIVE, SPECIAL OR INCIDENTAL DAMAGES (INCLUDING, WITHOUT LIMITATION, DAMAGES FOR LOSS AND PROFITS, BUSINESS INTERRUPTION, OR LOSS OF INFORMATION) ARISING OUT OF THE USE OR INABILITY TO USE THIS DOCUMENT, EVEN IF ATMEL HAS BEEN ADVISED OF THE POSSIBILITY OF SUCH DAMAGES. Atmel makes no representations or warranties with respect to the accuracy or completeness of the contents of this document and reserves the right to make changes to specifications and products descriptions at any time without notice. Atmel does not make any commitment to update the information contained herein. Unless specifically provided otherwise, Atmel products are not suitable for, and shall not be used in, automotive applications. Atmel products are not intended, authorized, or warranted for use as components in applications intended to support or sustain life.

SAFETY-CRITICAL, MILITARY, AND AUTOMOTIVE APPLICATIONS DISCLAIMER: Atmel products are not designed for and will not be used in connection with any applications where the failure of such products would reasonably be expected to result in significant personal injury or death ("Safety-Critical Applications") without an Atmel officer's specific written consent. Safety-Critical Applications include, without limitation, life support devices and systems, equipment or systems for the operation of nuclear facilities and weapons systems. Atmel products are not designed nor intended for use in military or aerospace applications or environments unless specifically designated by Atmel as military-grade. Atmel products are not designed nor intended for use in automotive applications unless specifically designated by Atmel as automotive-grade.